

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/787,303	TOMIYAMA ET	AL.
Examiner	Art Unit	
Patrick Butler	1742	

	SEARCHED		
Class	Subclass	Date	Examiner
264	130	7/14/2006	LEL
264	134	7/14/2006	LEL
264	232	7/14/2006	LEL
264	234	7/14/2006	LEL
264	236	7/14/2006	LEL
264	347	7/14/2006	LEL
399	38	7/14/2006	LEL
399	99	7/14/2006	LEL
399	260	7/14/2006	LEL
399	350	7/14/2006	LEL
Above	UPDATED	4/18/2007	РВ
Above	UPDATED	11/1/2007	/PB/
Above	UPDATED	5/27/2008	/PB/
Above	UPDATED	2/11/2009	/PB/

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
US-PG Pub, USPat, USOCR, EPO, JPO, IBM_TDB data bases, inventor search, NPL search, and attached EAST Search History	7/14/2006	LEL	
EAST(US-PGPUB; USOCR; USPAT) - See Search History Printout	4/18/2007	РВ	
EAST (US-PGPUB; USOCR; USPAT; DERWENT; EPO; JPO; IBM_TDB; FPRS) - See Search History Printout	11/1/2007	/PB/	
EAST(US-PGPUB; USOCR; USPAT) - See Search History Printout	5/27/2008	/PB/	
EAST(US-PGPUB; USOCR; USPAT) - See Search History Printout	2/11/2009	/PB/	
EAST (US-PGPUB; USOCR; USPAT; DERWENT; EPO; JPO; IBM_TDB; FPRS) - See Search History Printout	7/28/2009	/PB/	
EAST(US-PGPUB; USOCR; USPAT) - See Search History Printout	6/16/2010	/PB/	
EAST(US-PGPUB; USOCR; USPAT) - See Search History Printout	12/2/2010	/PB/	

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